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List of P	atents an	d Publications for .	Applicant's	Applicant			-	
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INF	ORMATIO	N DISCLOSURE ST	ATEMENT	and Wolfgang	Buchnoitz			
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EXAMINER: INITIAL IF REFERENCE CONSIDERED, WHETHER OR NOT CITATION IS IN CONFORMANCE WITH MPEP 109; DRAW LINE THROUGH CITATION IF NOT IN CONFORMANCE AND NOT CONSIDERED. INCLUDE COPY OF THIS FORM WITH NEXT COMMUNICATION TO APPLICANT.

Form PTO-1449 (modified)

List of Patents and Publications Total

INFORMATION DISCLOSURE STATEMENT

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Atty. Docket No. Serial No. 2000.110600/DE0347 10/790,852 Applicant Karsten Wieczorek, Thomas Feudel, Thorsten Kammler and Wolfgang Buchholtz

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